

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/845,245	WANG ET AL.	
Examiner		Art Unit		Page 1 of 1
Susan Hanley		1651		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,778,724	08-2004	Wang et al.	385/16
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fuhr et al. "Force Measurements of Optical Tweezers in Electro-Optical Cages," Appl. Physics A (1998) A67(4): 385-90.
	V	Tsai et al. "Applications of Optical Tweezers and an Integrated Force Measurement Module for Biomedical Research," Proceedings of SPIE Vol. 4082 (July 2000) p. 213-221.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.